Notice of References Cited Application/Control No. 10/710,295 Examiner TUYETLIEN T. TRAN Applicant(s)/Patent Under Reexamination ZUKOWSKI ET AL. Page 1 of 4

U.S. PATENT DOCUMENTS

		Document Number	Date		
*		Country Code-Number-Kind Code	MM-YYYY	Name	Classification
*	Α	US-5,319,747 A	06-1994	Gerrissen et al.	715/839
*	В	US-5,436,639 A	07-1995	Arai et al.	345/156
*	O	US-5,511,148 A	04-1996	Wellner, Pierre D.	358/1.6
*	ם	US-5,732,227 A	03-1998	Kuzunuki et al.	715/775
*	ш	US-5,808,605 A	09-1998	Shieh, Johnny Meng-Han	345/173
*	F	US-5,845,282 A	12-1998	Alley et al.	707/10
*	O	US-6,005,547 A	12-1999	Newman et al.	345/156
*	Ι	US-6,043,805 A	03-2000	Hsieh, Kuan-Hong	345/158
*	_	US-6,061,004 A	05-2000	Rosenberg, Louis B.	341/20
*	7	US-6,119,186 A	09-2000	Watts et al.	710/104
*	K	US-6,160,899 A	12-2000	Lee et al.	382/103
*	L	US-6,222,465 B1	04-2001	Kumar et al.	341/20
*	М	US-6,266,048 B1	07-2001	Carau, Sr., Frank P.	345/168

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	W	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No. 10/710,295 Examiner TUYETLIEN T. TRAN Applicant(s)/Patent Under Reexamination ZUKOWSKI ET AL. Page 2 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2001/0036324 A1	11-2001	Altman, Gerald	382/305
*	В	US-2001/0056463 A1	12-2001	Grady et al.	709/203
*	С	US-2002/0087470 A1	07-2002	Hayes et al.	705/40
*	D	US-6,446,208 B1	09-2002	Gujar et al.	713/185
*	Е	US-2003/0018541 A1	01-2003	Nohr, Steven Paul	705/26
*	F	US-2003/0046401 A1	03-2003	Abbott et al.	709/228
*	G	US-6,549,933 B1	04-2003	Barrett et al.	709/203
*	Н	US-6,573,916 B1	06-2003	Grossweiler et al.	715/850
*	I	US-2003/0103238 A1	06-2003	MacLean et al.	358/1.18
*	J	US-2003/0139968 A1	07-2003	Ebert, Peter S.	705/22
*	К	US-2003/0163787 A1	08-2003	Hay et al.	715/522
*	L	US-6,614,422 B1	09-2003	Rafii et al.	345/168
*	М	US-2003/0197687 A1	10-2003	Shetter, Martin	345/173

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	С	
	>	
	w	
	x	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No. 10/710,295 Examiner TUYETLIEN T. TRAN Applicant(s)/Patent Under Reexamination ZUKOWSKI ET AL. Art Unit Page 3 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0217267 A1	11-2003	Kindberg, Timothy P.J.G.	713/168
*	В	US-6,684,325 B1	01-2004	Nihei, Katsumi	713/1
*	O	US-6,690,156 B1	02-2004	Weiner et al.	324/207.17
*	D	US-6,772,099 B2	08-2004	Merkin et al.	702/188
*	Е	US-6,771,294 B1	08-2004	Pulli et al.	715/863
*	F	US-2004/0183824 A1	09-2004	Benson et al.	345/719
*	G	US-2004/0254767 A1	12-2004	Merkin et al.	702/188
*	Н	US-2005/0131959 A1	06-2005	Thorman et al.	707/200
*	ı	US-2005/0213790 A1	09-2005	Rhoads et al.	382/100
*	J	US-7,089,288 B2	08-2006	Gossweiler III et al.	709/208
*	K	US-7,139,685 B2	11-2006	Bascle et al.	703/1
*	L	US-7,173,605 B2	02-2007	Fong et al.	345/168
*	М	US-7,290,708 B2	11-2007	Haller, Stephan	235/385

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	С	
	>	
	w	
	x	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No. 10/710,295 Examiner TUYETLIEN T. TRAN Applicant(s)/Patent Under Reexamination ZUKOWSKI ET AL. Page 4 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,307,661 B2	12-2007	Lieberman et al.	348/333.1
	В	US-			
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	-	US-			
	J	US-			
	К	US-			
	لــ	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	Ø					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	С	
	>	
	w	
	x	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.